



SLOVENSKI STANDARD
SIST EN 61010-031:2015/oprA1:2017
01-julij-2017

Varnostne zahteve za električno opremo za meritve, nadzorovanje in laboratorijsko uporabo - 031. del: Varnostne zahteve za ročne sonde za električne meritve in preskušanje

Safety requirements for electrical equipment for measurement, control and laboratory use - Part 031: Safety requirements for hand-held and hand-manipulated probe assemblies for electrical test and measurement

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[SIST EN 61010-031:2015/oprA1:2018](https://standards.iteh.ai/catalog/standards/sist/185ed8d7-0f52-43ea-8d15-f453b2a4e571/sist-en-61010-031-2015-opra1-2018)
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Ta slovenski standard je istoveten z: EN 61010-031:2015/prA1:2017

ICS:

19.080	Električno in elektronsko preskušanje	Electrical and electronic testing
71.040.10	Kemijski laboratoriji. Laboratorijska oprema	Chemical laboratories. Laboratory equipment

SIST EN 61010-031:2015/oprA1:2017 **en,fr,de**

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66/632/CDV

COMMITTEE DRAFT FOR VOTE (CDV)

PROJECT NUMBER:

IEC 61010-031/AMD1 ED2

DATE OF CIRCULATION:

2017-05-19

CLOSING DATE FOR VOTING:

2017-08-11

SUPERSEDES DOCUMENTS:

IEC TC 66 : SAFETY OF MEASURING, CONTROL AND LABORATORY EQUIPMENT	
SECRETARIAT: United Kingdom	SECRETARY: Mr David Hyde
OF INTEREST TO THE FOLLOWING COMMITTEES: TC 78, TC 85	PROPOSED HORIZONTAL STANDARD: <input checked="" type="checkbox"/> GROUP SAFETY FUNCTION Other TC/SCs are requested to indicate their interest, if any, in this CDV to the secretary.
FUNCTIONS CONCERNED: <input type="checkbox"/> EMC <input type="checkbox"/> ENVIRONMENT <input type="checkbox"/> QUALITY ASSURANCE <input checked="" type="checkbox"/> SAFETY	
<input checked="" type="checkbox"/> SUBMITTED FOR CENELEC PARALLEL VOTING	<input type="checkbox"/> NOT SUBMITTED FOR CENELEC PARALLEL VOTING

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This document is still under study and subject to change. It should not be used for reference purposes.

Recipients of this document are invited to submit, with their comments, notification of any relevant patent rights of which they are aware and to provide supporting documentation.

TITLE:

Safety requirements for electrical equipment for measurement, control and laboratory use – Part 031: Safety requirements for hand-held and hand-manipulated probe assemblies for electrical test and measurement.

NOTE FROM TC/SC OFFICERS:

1

FOREWORD

2 This amendment has been prepared by IEC technical committee 66: Safety of measuring,
3 control and laboratory equipment.

4 The text of this standard is based on the following documents:

FDIS	Report on voting
66/XX/FDIS	66/XX/RVD

5

6 Full information on the voting for the approval of this standard can be found in the report on
7 voting indicated in the above table.

8 The committee has decided that the contents of this publication will remain unchanged until
9 the stability date indicated on the IEC web site under "http://webstore.iec.ch" in the data
10 related to the specific publication. At this date, the publication will be

- 11 • reconfirmed,
- 12 • withdrawn,
- 13 • replaced by a revised edition, or
- 14 • amended.

15

16 The National Committees are requested to note that for this publication the stability date
17 is 2021.

18 THIS TEXT IS INCLUDED FOR THE INFORMATION OF THE NATIONAL COMMITTEES AND WILL BE DELETED
19 AT THE PUBLICATION STAGE.

20

[https://standards.iteh.ai/catalog/standards/sist/185ed8d7-0f52-43ea-8d15-](https://standards.iteh.ai/catalog/standards/sist/185ed8d7-0f52-43ea-8d15-53b2a4e571/sist-en-61010-031-2015-opra1-2018)

21 Change the sub-title to read: [53b2a4e571/sist-en-61010-031-2015-opra1-2018](https://standards.iteh.ai/catalog/standards/sist/185ed8d7-0f52-43ea-8d15-53b2a4e571/sist-en-61010-031-2015-opra1-2018)

22

23 **Part 031: Safety requirements for hand-held and hand-manipulated probe** 24 **assemblies for electrical test and measurement**

25

26 **1 Scope and object**

27 **1.1.1 Probe assemblies included in Scope**

28 Figure 4, Key 3

29 *Deletion*

30 *Delete the words "or clamp"*

31 **2 Normative references**

32 **3 Terms and definitions**

33 **3.1.1**

34 **TERMINAL**

35 Note 1 to entry

36 *Deletion*

37 *Delete the word "connectors"*

38 **3.1.5**

39 **CONNECTOR**

40 *Deletion*

41 *Delete the word “connector” so the sentence will read:*

42 “...to connect to a TERMINAL of the equipment or to another probe assembly”

43 **3.4.11**

44 **MEASUREMENT CATEGORY**

45 *Replacement*

46 *Replace the text with the following:*

47 classification of testing and measuring circuits according to the types of mains to which they
48 are intended to be connected

49 **4 Tests**

50 **4.3.9 Duty cycle**

51 *Replacement*

52 *Replace the title with the following:*

53 **4.3.9 Short-term or intermittent operation**

54 **4.4.4.2 Temperature**

55 *Replacement*

56 *Replace the second paragraph with the following:*

57 *This temperature is determined by measuring the temperature rise of the surface or part and*
58 *adding it to the ambient temperature of 40 °C, or to the maximum RATED ambient temperature*
59 *if higher.*

60 **4.5.2 Fuses**

61 *Replacement*

62 *Replace the fourth sentence of the second paragraph with the following:*

63 With respect to prospective short circuit currents associated with mains installations, the fuse
64 shall be RATED according to 12.2 and no additional testing related to the interrupt current
65 RATING is necessary.

66 **5 Marking and documentation**

67 **5.1.5 RATING**

68 *Replacement*

69 *Replace the second paragraph by the following:*

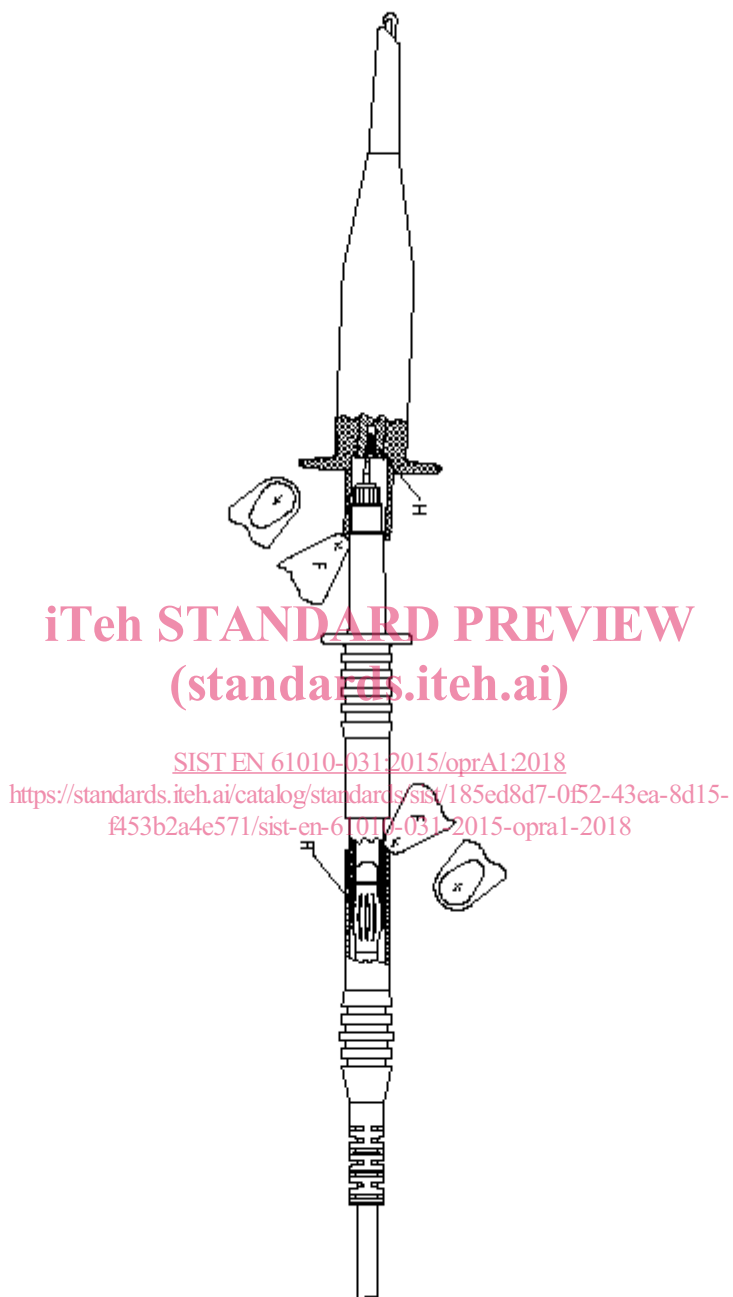
70 a) Probe assemblies which do not have a RATING for MEASUREMENT CATEGORIES II, III or IV
71 (see 6.5.2) shall be marked with the RATED voltage to earth and with symbol 7 of Table 1
72 (see also 5.4.3 k)).

73 **6 Protection against electric shock**

74 **6.2.2 Examination**

75 *Replacement*

76 *Replace figures 6c and 6d by the following figures*

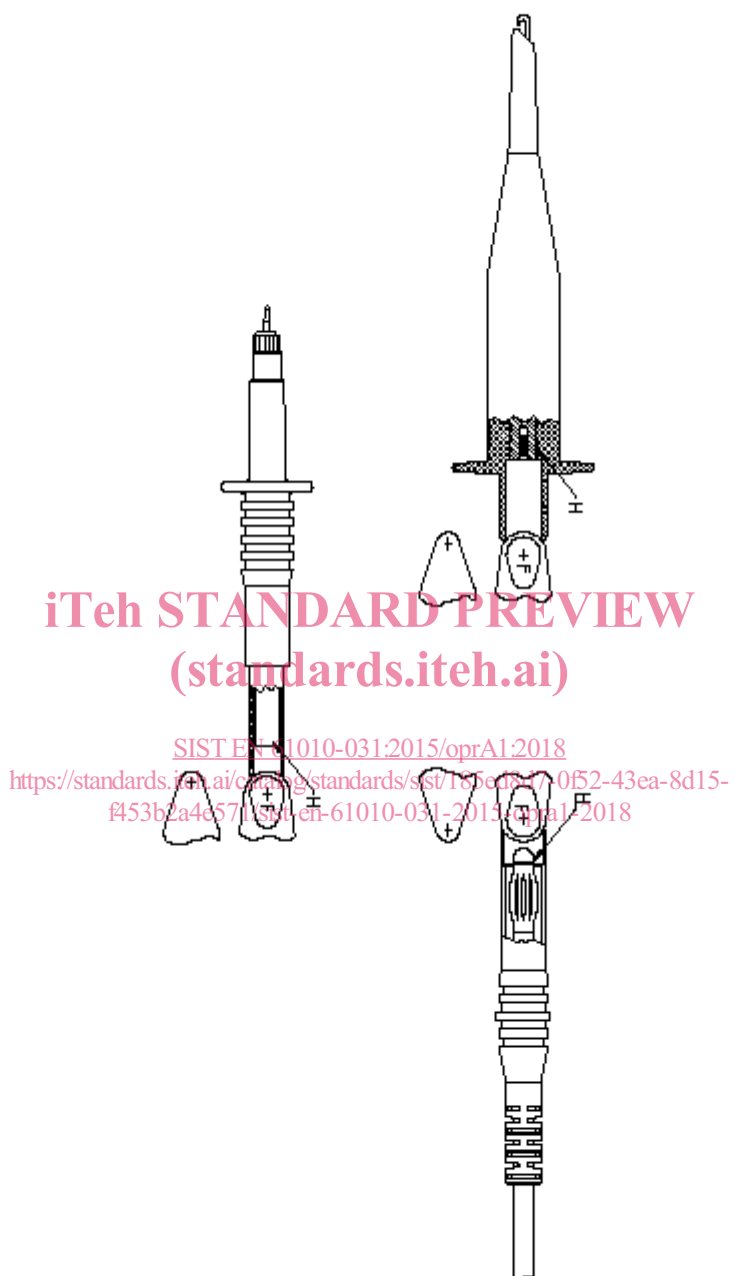


77

78 Connecting parts are partially mated so as just to make electrical contact while allowing maximum access to the
79 test finger. Note the two possible positions of the testfinger.

80

Figure 6c – Partially mated probe assemblies (see 6.2 and 6.4.2 b))



81

82 Key

83 F rigid test finger (see Figure B.1)

84 H potentially HAZARDOUS LIVE part

85 Note the two possible positions of the testfinger

86

Figure 6d – Unmated parts of a probe assembly (see 6.2 and 6.4.2 c))

87 **6.3.4.1 General**

88 **Figure 8**

89 *Replacement*

90 *Replace the list with the following:*

91 a) *the probe body;*

92 b) *hand-held or hand-manipulated parts of each CONNECTOR;*

93 c) *150 mm ± 20 mm of the PROBE WIRE or the maximum length of the cable whichever is*
94 *shorter;*

95 d) *other hand-held or hand-manipulated parts.*

96

97 *Deletion*

98 *Delete in the key 2c) the following:*

99 (see 12.3.2)

100

101 **6.3.4.2 Probe assemblies with floating outer connection**

102 **Figure 10**

103 *Deletion*

104 *Delete in the key 2c) the following:*

105 (see 12.3.2)

106 **6.4.1 General**

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107 *Replacement*

108 *Replace the list in the fourth paragraph by the following:*

109 a) DOUBLE INSULATION, consisting of BASIC INSULATION plus SUPPLEMENTARY INSULATION (see
110 6.4.6)

111 b) BASIC INSULATION plus impedance (see 6.4.4)

112 c) REINFORCED INSULATION (see 6.4.6)

113 d) PROTECTIVE IMPEDANCE (see 6.4.5)

114 **6.4.3.2 Protection by a PROTECTIVE FINGERGUARD**

115 *Replacement*

116 *Replace the third paragraph by the following:*

117 The height of the protective FINGERGUARD from the side where the fingers are intended to be
118 applied shall be at least 2 mm.

119 **6.4.3.4 Protection by tactile indicator**

120 *Replacement*

121 *Replace the first paragraph by the following:*

122 SPRING-LOADED CLIPS RATED for MEASUREMENT CATEGORY II or without MEASUREMENT CATEGORY
123 for maximum 300 V which require finger pressure at about 90° to the axis of the clip are
124 acceptable without a PROTECTIVE FINGERGUARD, provided that there is a tactile indicator to
125 indicate the limit of safe access for the OPERATOR.

126 **6.4.3.5 Probe tips used as connectors**

127 *Replacement*

128 *Replace the text with the following text:*

129 PROBE TIPS which can be used as CONNECTORS and are intended to be connected to specified
 130 accessories (for example to a SPRING-LOADED CLIP) shall, in combination with those
 131 accessories, also meet the requirements for CONNECTORS in fully-mated position and partially-
 132 mated position (see 6.4.2 a) and b)).

133 6.5.1.2.4 Solid insulation

134 6.5.1.2.4.1 General

135 Replacement

136 Replace the text and the Table 4 by the following:

137 Solid insulation shall withstand the electrical and mechanical stresses that may occur in
 138 NORMAL USE, in all RATED environmental conditions (see 1.4), during the intended life of the
 139 equipment.

140 The manufacturer should take the expected life of the equipment into account when selecting
 141 insulating materials.

142 Conformity is checked by both of the following tests for probe assemblies RATED for use in
 143 MEASUREMENT CATEGORIES II, III or IV:

- 144 a) the a.c. voltage test of 6.6.5.1 with a duration of at least 5 s or the impulse voltage test of
 145 6.6.5.3 or, using the applicable test voltage of Table 4 or Table 4a;
- 146 b) the a.c. voltage test of 6.6.5.1 with a duration of at least 1 min or, for measuring circuits
 147 stressed only by d.c., the d.c. voltage test of 6.6.5.2 with a duration of at least 1 min using
 148 the formula: $\text{Testvoltage} = 1,5 \text{ times RATED voltage} + 750 \text{ V}$.

149 NOTE Test a) checks the effects of TRANSIENT OVERVOLTAGES, while test b) checks the effects of long-term stress
 150 of solid insulation.

151

152 **Table 4 – Test voltages for testing electric strength**
 153 **of solid insulation in measuring circuits of MEASUREMENT CATEGORY II**

RATED a.c. r.m.s. or d.c. voltage to earth	Testvoltage a.c. r.m.s					
	BASIC INSULATION and SUPPLEMENTARY INSULATION			REINFORCED INSULATION		
	MEASUREMENT CATEGORY II	MEASUREMENT CATEGORY III	MEASUREMENT CATEGORY IV	MEASUREMENT CATEGORY II	MEASUREMENT CATEGORY III	MEASUREMENT CATEGORY IV
≤ 50	480	530	840	530	710	1 390
> 50 ≤ 100	530	840	1 390	710	1 390	2 210
> 100 ≤ 150	840	1 390	2 210	1 390	2 210	3 510
> 150 ≤ 300	1 390	2 210	3 310	2 210	3 510	5 160
> 300 ≤ 600	2 210	3 310	4 260	3 510	5 160	6 270
> 600 ≤ 1 000	3 310	4 260	6 590	5 160	6 270	10 540
> 1 000 ≤ 1 500	4 260	5 370	6 970	7 400	9 700	14 800
> 1 500 ≤ 2 000	6 590	6 970	9 710	11 900	14 800	17 600
> 2 000 ≤ 3 000	6 970	9 710	10 800	14 800	17 600	19 600

154